## DATA SHEET

## 74ALVT16899 <br> 2.5V/3.3V 18-bit latched transceiver with 16-bit parity generator/checker (3-State)

### 2.5V/3.3V 18-bit latched transceiver with 16-bit parity generator/checker (3-State)

## 74ALVT16899

## FEATURES

- Symmetrical (A and B bus functions are identical)
- Selectable generate parity or "feed-through" parity for A-to-B and B-to-A directions
- Independent transparent latches for A-to-B and B-to-A directions
- Selectable ODD/EVEN parity
- Continuously checks parity of both $A$ bus and $B$ bus latches as ERRA and ERRB
- Open-collector ERR output
- Ability to simultaneously generate and check parity
- Can simultaneously read/latch A and B bus data
- Output capability: $+64 \mathrm{~mA} /-32 \mathrm{~mA}$
- Latch-up protection exceeds 500mA per Jedec Std 17
- ESD protection exceeds 2000 V per MIL STD 883 Method 3015 and 200 V per Machine Model
- Power up 3-State
- Power-up reset
- No bus current loading when output is tied to 5 V bus
- Live insertion/extraction permitted
- Bus-hold data inputs eliminate the need for external pull-up resistors to hold unused inputs


## DESCRIPTION

The 74ALVT16899 is a high-performance BiCMOS product designed for $\mathrm{V}_{\mathrm{CC}}$ operation at 2.5 V or 3.3 V with $\mathrm{I} / \mathrm{O}$ compatibility up to 5 V .
The 74ALVT16899 is a 16-bit to 16 -bit parity transceiver with separate transparent latches for the $A$ bus and $B$ bus. Either bus
can generate or check parity. The parity bit can be fed-through with no change or the generated parity can be substituted with the SEL input.

The 74ALVT16899 features independent latch enables for the A and $B$ bus latches, a select pin for ODD/EVEN parity, and separate error signal output pins for checking parity.

## FUNCTIONAL DESCRIPTION:

The 74ALVT16899 has three principal modes of operation which are outlined below. All modes apply to both the A-to-B and B-to-A directions.

Transparent latch, Generate parity, Check $A$ and $B$ bus parity: Bus $A(B)$ communicates to Bus $B(A)$, parity is generated and passed on to the $B(A)$ Bus as BPAR (APAR). If LEA and LEB are High and the Mode Select (SEL) is Low, the parity generated from A0-A7 and B0-B7 can be checked and monitored by ERRA and ERRB. (Fault detection on both input and output buses.)

Transparent latch, Feed-through parity, Check A and B bus parity:
Bus A (B) communicates to Bus B (A) in a feed-through mode if SEL is High. Parity is still generated and checked as ERRA and ERRB and can be used as an interrupt to signal a data/parity bit error to the CPU.

Latched input, Generate/Feed-through parity, Check A (and B) bus parity:
Independent latch enables (LEA and LEB) allow other permutations of:

- Transparent latch / 1 bus latched / both buses latched
- Feed-through parity / generate parity
- Check in bus parity / check out bus parity / check in and out bus parity


## QUICK REFERENCE DATA

| SYMBOL | PARAMETER | CONDITIONS$\mathrm{T}_{\mathrm{amb}}=25^{\circ} \mathrm{C} ; \mathrm{GND}=0 \mathrm{~V}$ | TYPICAL |  | UNIT |
| :---: | :---: | :---: | :---: | :---: | :---: |
|  |  |  | 2.5 V | 3.3 V |  |
| $\begin{aligned} & \text { tpLH } \\ & t_{\text {tPHL }} \end{aligned}$ | Propagation delay <br> An to Bn or Bn to An | $\mathrm{C}_{\mathrm{L}}=50 \mathrm{pF}$ | $\begin{aligned} & 2.0 \\ & 2.2 \end{aligned}$ | $\begin{aligned} & 1.5 \\ & 1.7 \end{aligned}$ | ns |
| $\begin{aligned} & \text { tplH } \\ & t_{\text {tPHL }} \end{aligned}$ | Propagation delay An to ERRA | $\mathrm{C}_{\mathrm{L}}=50 \mathrm{pF}$ | $\begin{aligned} & 9.8 \\ & 7.0 \end{aligned}$ | $\begin{aligned} & 7.8 \\ & 5.1 \end{aligned}$ | ns |
| $\mathrm{C}_{\text {IN }}$ | Input capacitance | $\mathrm{V}_{1}=0 \mathrm{~V}$ or $\mathrm{V}_{\text {cc }}$ | 3 | 3 | pF |
| $\mathrm{C}_{\text {I/O }}$ | Output capacitance | Outputs disabled; $\mathrm{V}_{\mathrm{O}}=0 \mathrm{~V}$ or $\mathrm{V}_{\mathrm{CC}}$ | 9 | 9 | pF |
| I CCz | Quiescent supply current | Outputs disabled | 40 | 70 | $\mu \mathrm{A}$ |

## ORDERING INFORMATION

| PACKAGES | TEMPERATURE RANGE | OUTSIDE NORTH AMERICA | NORTH AMERICA | DWG NUMBER |
| :--- | :---: | :---: | :---: | :---: |
| $56-$ Pin Plastic SSOP Type III | $-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$ | $74 \mathrm{ALVT16899}$ | AV16899 DL | SOT371-1 |
| $56-$ Pin Plastic TSSOP Type II | $-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$ | $74 \mathrm{ALVT16899}$ DGG | AV16899 DGG | SOT364-1 |

## PIN CONFIGURATION



PIN DESCRIPTION

| SYMBOL | $\begin{gathered} \text { PIN } \\ \text { NUMBER } \end{gathered}$ | NAME AND FUNCTION |
| :---: | :---: | :---: |
| $\begin{aligned} & 1 \mathrm{AO}-1 \mathrm{~A} 7 \\ & 2 \mathrm{AO}-2 \mathrm{~A} 7 \end{aligned}$ | $\begin{gathered} 3,5,6,7,8,10,11,12 \\ 27,25,24,23,22,20,19,18 \end{gathered}$ | Latched A bus 3-State inputs/outputs |
| $\begin{aligned} & \hline \text { 1B0-1B7 } \\ & 2 \mathrm{BO} 0-2 \mathrm{~B} 7 \end{aligned}$ | $\begin{aligned} & 54,52,51,50,49,47,46,45 \\ & 30,32,33,34,35,37,38,39 \end{aligned}$ | Latched B bus 3-State inputs/outputs |
| $\begin{aligned} & \hline \text { 1APAR } \\ & \text { 2APAR } \end{aligned}$ | 13, 17 | A bus parity 3-State input/output |
| 1BPAR 2BPAR | 44, 40 | B bus parity 3-State input/output |
| ODD/EVEN | 1 | Parity select input (Low for EVEN parity) |
| OEA, OEB | 2, 29 | Output enable inputs (gate A to B, B to A) |
| $\overline{S E L}$ | 56 | Mode select input (Low for generate) |
| LEA, LEB | 55, 28 | Latch enable inputs (transparent High) |
| 1ERRA, 1ERRB 2ERRA, 2ERRB | $\begin{aligned} & \hline 14,43, \\ & 16,41 \end{aligned}$ | Error signal outputs (active-Low) |
| GND | 4, 15, 26, 31, 42, 53 | Ground (0V) |
| $\mathrm{V}_{\mathrm{CC}}$ | 9, 21, 36, 48 | Positive supply voltage |

## LOGIC SYMBOL



PARITY AND ERROR FUNCTION TABLE

| INPUTS |  |  |  | OUTPUTS |  |  | PARITY MODES |  |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| SEL | ODD/EVEN | $\begin{aligned} & \text { xPAR } \\ & (\text { A or B) } \end{aligned}$ | $\Sigma$ of High Inputs | $\begin{gathered} \text { xPAR } \\ (\mathrm{B} \text { or } \mathrm{A}) \end{gathered}$ | ERRt | ERRr* |  |  |
| H | H | H | Even Odd | $\begin{aligned} & \mathrm{H} \\ & \mathrm{H} \end{aligned}$ | $\begin{gathered} \mathrm{H} \\ \mathrm{~L} \end{gathered}$ | $\stackrel{H}{\mathrm{H}}$ | Odd <br> Mode | Feed-through/check parity |
| H | H | L | $\begin{aligned} & \hline \text { Even } \\ & \text { Odd } \end{aligned}$ | $\begin{aligned} & \mathrm{L} \\ & \mathrm{~L} \end{aligned}$ | $\begin{aligned} & \mathrm{L} \\ & \mathrm{H} \end{aligned}$ | $\begin{aligned} & \mathrm{L} \\ & \mathrm{H} \end{aligned}$ |  |  |
| H | L | H | $\begin{aligned} & \hline \text { Even } \\ & \text { Odd } \end{aligned}$ | $\begin{aligned} & \mathrm{H} \\ & \mathrm{H} \end{aligned}$ | $\begin{aligned} & \mathrm{L} \\ & \mathrm{H} \end{aligned}$ | $\begin{aligned} & \mathrm{L} \\ & \mathrm{H} \end{aligned}$ | Even <br> Mode |  |
| H | L | L | $\begin{aligned} & \text { Even } \\ & \text { Odd } \end{aligned}$ | $\begin{aligned} & \mathrm{L} \\ & \mathrm{~L} \end{aligned}$ | $\underset{M}{H}$ | $\begin{gathered} \mathrm{H} \\ \mathrm{~L} \end{gathered}$ |  |  |
| L | H | H | $\begin{aligned} & \text { Even } \\ & \text { Odd } \end{aligned}$ | $\underset{\mathrm{H}}{\mathrm{H}}$ | $\stackrel{H}{\mathrm{H}}$ | $\begin{aligned} & \mathrm{H} \\ & \mathrm{H} \end{aligned}$ | Odd <br> Mode | Generate parity |
| L | H | L | Even Odd | $\stackrel{H}{\mathrm{H}}$ | $\begin{aligned} & \mathrm{L} \\ & \mathrm{H} \end{aligned}$ | $\begin{aligned} & \mathrm{H} \\ & \mathrm{H} \end{aligned}$ |  |  |
| L | L | H | $\begin{aligned} & \hline \text { Even } \\ & \text { Odd } \end{aligned}$ | $\begin{aligned} & \mathrm{L} \\ & \mathrm{H} \end{aligned}$ | $\begin{aligned} & \mathrm{L} \\ & \mathrm{H} \end{aligned}$ | $\begin{aligned} & \mathrm{H} \\ & \mathrm{H} \end{aligned}$ | Even <br> Mode |  |
| L | L | L | $\begin{aligned} & \hline \text { Even } \\ & \text { Odd } \end{aligned}$ | $\begin{aligned} & \mathrm{L} \\ & \mathrm{H} \end{aligned}$ | $\begin{gathered} \mathrm{H} \\ \mathrm{~L} \end{gathered}$ | $\begin{aligned} & \mathrm{H} \\ & \mathrm{H} \end{aligned}$ |  |  |

$\mathrm{H}=$ High voltage level
L = Low voltage level
$t=$ Transmit-if the data path is from $A \rightarrow B$ then ERRt is ERRA
$r=$ Receive-if the data path is from $A \rightarrow B$ then $\overline{E R R r}$ is ERRB

* Blocked if latch is not transparent


## BLOCK DIAGRAM



FUNCTION TABLE

| OPERATING MODE |  |  |  |  |  |
| :---: | :---: | :---: | :---: | :---: | :--- | :--- |
| $\mathbf{O E B}$ | OEA | SEL | LEA | LEB |  |
| H | H | X | X | X |  |
| H | L | L | L | H |  |
| H | L | L | H | H |  |
| H | L | L | X | L | B $\rightarrow$ A, B bus latched, generate parity from latched B0 - B7 data, check B bus parity |
| H | L | H | X | H | B $\rightarrow$ A, transparent B latch, parity feed-through, check B bus parity |
| H | L | H | H | H | B $\rightarrow$ A, transparent A \& B latch, parity feed-through, check A \& B bus parity |
| L | H | L | H | X | A $\rightarrow$ B, transparent A latch, generate parity from A0 - A7, check A bus parity |
| L | H | L | H | H | A $\rightarrow$ B, transparent A \& B latch, generate parity from A0 - A7, check A \& B bus parity |
| L | H | L | L | X | A $\rightarrow$ B, A bus latched, generate parity from latched A0 - A7 data, check A bus parity |
| L | H | H | H | L | A $\rightarrow$ B, transparent A latch, parity feed-through, check A bus parity |
| L | H | H | H | H | A $\rightarrow$ B, transparent A \& B latch, parity feed-through, check A \& B bus parity |
| L | L | X | X | X | Output to A bus and B bus (NOT ALLOWED) |

$H=$ High voltage level
$L=$ Low voltage level
$X=$ Don't care

### 2.5V/3.3V 18-bit latched transceiver with 16-bit parity generator/checker (3-State)

ABSOLUTE MAXIMUM RATINGS ${ }^{1,2}$

| SYMBOL | PARAMETER | CONDITIONS | RATING | UNIT |
| :---: | :--- | :---: | :---: | :---: |
| $\mathrm{V}_{\mathrm{CC}}$ | DC supply voltage |  | -0.5 to +4.6 | V |
| $\mathrm{I}_{\mathrm{IK}}$ | DC input diode current | $\mathrm{V}_{\mathrm{I}}<0$ | -50 | mA |
| $\mathrm{~V}_{\mathrm{I}}$ | DC input voltage ${ }^{3}$ |  | -0.5 to +7.0 | V |
| $\mathrm{I}_{\text {OK }}$ | DC output diode current | $\mathrm{V}_{\mathrm{O}}<0$ | -50 | mA |
| $\mathrm{~V}_{\text {OUT }}$ | DC output voltage ${ }^{3}$ | Output in Off or High state | -0.5 to +7.0 | V |
| $\mathrm{I}_{\text {OUT }}$ | DC output current | Output in Low state | 128 | mA |
|  | Storage temperature range | Output in High state | -64 |  |

NOTES:

1. Stresses beyond those listed may cause permanent damage to the device. These are stress ratings only and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.
2. The performance capability of a high-performance integrated circuit in conjunction with its thermal environment can create junction temperatures which are detrimental to reliability. The maximum junction temperature of this integrated circuit should not exceed $150^{\circ} \mathrm{C}$.
3. The input and output negative voltage ratings may be exceeded if the input and output clamp current ratings are observed.

## RECOMMENDED OPERATING CONDITIONS

| SYMBOL | PARAMETER | 2.5V RANGE LIMITS |  | 3.3V RANGE LIMITS |  | UNIT |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  | MIN | MAX | MIN | MAX |  |
| $\mathrm{V}_{\text {CC }}$ | DC supply voltage | 2.3 | 2.7 | 3.0 | 3.6 | V |
| $\mathrm{V}_{1}$ | Input voltage | 0 | 5.5 | 0 | 5.5 | V |
| $\mathrm{V}_{\mathrm{IH}}$ | High-level input voltage | 1.7 |  | 2.0 |  | V |
| $\mathrm{V}_{\text {IL }}$ | Input voltage |  | 0.7 |  | 0.8 | V |
| $\mathrm{IOH}^{\text {l }}$ | High-level output current |  | -8 |  | -32 | mA |
| ${ }^{\text {loL }}$ | Low-level output current |  | 8 |  | 32 | mA |
|  | Low-level output current; current duty cycle $\leq 50 \%$; f $\geq 1 \mathrm{kHz}$ |  | 24 |  | 64 |  |
| $\Delta t / \Delta v$ | Input transition rise or fall rate; Outputs enabled |  | 10 |  | 10 | ns/V |
| $\mathrm{T}_{\text {amb }}$ | Operating free-air temperature range | -40 | +85 | -40 | +85 | ${ }^{\circ} \mathrm{C}$ |

### 2.5V/3.3V 18-bit latched transceiver with 16-bit parity generator/checker (3-State)

## DC ELECTRICAL CHARACTERISTICS (3.3V $\pm 0.3 \mathrm{~V}$ RANGE)

| SYMBOL | PARAMETER | TEST CONDITIONS |  |  | IMITS |  | UNIT |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  |  |  | Temp $=-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$ |  |  |  |
|  |  |  |  | MIN | TYP ${ }^{1}$ | MAX |  |
| $\mathrm{V}_{\mathrm{IK}}$ | Input clamp voltage | $\mathrm{V}_{\mathrm{CC}}=3.0 \mathrm{~V} ; \mathrm{I}_{\mathrm{IK}}=-18 \mathrm{~mA}$ |  |  | -0.85 | -1.2 | V |
| $\mathrm{VOH}_{\mathrm{OH}}$ | High-level output voltage | $\mathrm{V}_{\mathrm{CC}}=3.0$ to $3.6 \mathrm{~V} ; \mathrm{l}_{\mathrm{OH}}=-100 \mu \mathrm{~A}$ |  | $\mathrm{V}_{\mathrm{CC}}-0.2$ | $\mathrm{V}_{\text {CC }}$ |  | V |
|  |  | $\mathrm{V}_{\mathrm{CC}}=3.0 \mathrm{~V} ; \mathrm{I}_{\mathrm{OH}}=-32 \mathrm{~mA}$ |  | 2.0 | 2.3 |  |  |
| $\mathrm{V}_{\text {OL }}$ | Low-level output voltage | $\mathrm{V}_{\mathrm{CC}}=3.0 \mathrm{~V} ; \mathrm{l}_{\mathrm{OL}}=100 \mu \mathrm{~A}$ |  |  | 0.07 | 0.2 | V |
|  |  | $\mathrm{V}_{\mathrm{CC}}=3.0 \mathrm{~V} ; \mathrm{l}_{\mathrm{OL}}=16 \mathrm{~mA}$ |  |  | 0.25 | 0.4 |  |
|  |  | $\mathrm{V}_{\mathrm{CC}}=3.0 \mathrm{~V} ; \mathrm{I}_{\text {OL }}=32 \mathrm{~mA}$ |  |  | 0.3 | 0.5 |  |
|  |  | $\mathrm{V}_{\mathrm{CC}}=3.0 \mathrm{~V} ; \mathrm{l}_{\mathrm{OL}}=64 \mathrm{~mA}$ |  |  | 0.4 | 0.55 |  |
| $\mathrm{V}_{\text {RST }}$ | Power-up output low voltage ${ }^{6}$ | $\mathrm{V}_{\mathrm{CC}}=3.6 \mathrm{~V} ; \mathrm{I}_{\mathrm{O}}=1 \mathrm{~mA} ; \mathrm{V}_{\mathrm{I}}=\mathrm{V}_{\mathrm{CC}}$ or GND |  |  |  | 0.55 | V |
| 1 | Input leakage current | $\mathrm{V}_{C C}=3.6 \mathrm{~V} ; \mathrm{V}_{\mathrm{I}}=\mathrm{V}_{\text {CC }}$ or GND | Control pins |  | 0.1 | $\pm 1$ | $\mu \mathrm{A}$ |
|  |  | $\mathrm{V}_{\mathrm{CC}}=0$ or $3.6 \mathrm{~V} ; \mathrm{V}_{1}=5.5 \mathrm{~V}$ |  |  | 0.1 | 10 |  |
|  |  | $\mathrm{V}_{\mathrm{CC}}=3.6 \mathrm{~V} ; \mathrm{V}_{\mathrm{I}}=5.5 \mathrm{~V}$ | Data pins ${ }^{4}$ |  | 0.1 | 20 |  |
|  |  | $\mathrm{V}_{\mathrm{CC}}=3.6 \mathrm{~V} ; \mathrm{V}_{1}=\mathrm{V}_{\mathrm{CC}}$ |  |  | 0.5 | 1 |  |
|  |  | $\mathrm{V}_{\mathrm{CC}}=3.6 \mathrm{~V} ; \mathrm{V}_{\mathrm{I}}=0 \mathrm{~V}$ |  |  | 0.1 | -5 |  |
| IOFF | Off current | $\mathrm{V}_{\mathrm{CC}}=0 \mathrm{~V} ; \mathrm{V}_{\mathrm{l}}$ or $\mathrm{V}_{\mathrm{O}}=0$ to 4.5 V |  |  | 0.1 | $\pm 100$ | $\mu \mathrm{A}$ |
| Inold | Bus Hold current Data inputs | $\mathrm{V}_{\mathrm{CC}}=3 \mathrm{~V} ; \mathrm{V}_{\mathrm{I}}=0.8 \mathrm{~V}$ |  | 75 | 130 |  | $\mu \mathrm{A}$ |
|  |  | $\mathrm{V}_{\mathrm{CC}}=3 \mathrm{~V} ; \mathrm{V}_{1}=2.0 \mathrm{~V}$ |  | -75 | -140 |  |  |
|  |  | $\mathrm{V}_{\mathrm{I}}=0 \mathrm{~V}$ to $3.6 \mathrm{~V} ; \mathrm{V}_{\mathrm{CC}}=3.6 \mathrm{~V}^{7}$ |  | $\pm 500$ |  |  |  |
| $l_{\text {EX }}$ | Current into an output in the High state when $\mathrm{V}_{\mathrm{O}}>\mathrm{V}_{\mathrm{CC}}$ | $\mathrm{V}_{\mathrm{O}}=5.5 \mathrm{~V} ; \mathrm{V}_{\mathrm{CC}}=3.0 \mathrm{~V}$ |  |  | 10 | 125 | $\mu \mathrm{A}$ |
| IPU/PD | Power up/down 3-State output current ${ }^{3}$ | $\begin{aligned} & \mathrm{V}_{\mathrm{CC}} \leq 1.2 \mathrm{~V} ; \mathrm{V}_{\mathrm{O}}=0.5 \mathrm{~V} \text { to } \mathrm{V}_{\mathrm{CC}} ; \mathrm{V}_{\mathrm{I}}=\mathrm{GND} \text { or } \mathrm{V}_{\mathrm{CC}} \\ & \mathrm{OE} / \mathrm{OE}=\text { Don't care } \end{aligned}$ |  |  | 33 | $\pm 100$ | $\mu \mathrm{A}$ |
| lozh | 3-State output High current | $\mathrm{V}_{\mathrm{CC}}=3.6 \mathrm{~V} ; \mathrm{V}_{\mathrm{O}}=3.0 \mathrm{~V} ; \mathrm{V}_{\mathrm{I}}=\mathrm{V}_{\mathrm{IL}}$ or $\mathrm{V}_{\mathrm{IH}}$ |  |  | 0.5 | 5 | $\mu \mathrm{A}$ |
| IozL | 3-State output Low current | $\mathrm{V}_{\mathrm{CC}}=3.6 \mathrm{~V} ; \mathrm{V}_{\mathrm{O}}=0.5 \mathrm{~V} ; \mathrm{V}_{\mathrm{I}}=\mathrm{V}_{\mathrm{IL}}$ or $\mathrm{V}_{\mathrm{IH}}$ |  |  | 0.5 | -5 | $\mu \mathrm{A}$ |
| $\mathrm{I}_{\mathrm{CCH}}$ | Quiescent supply current | $\mathrm{V}_{\mathrm{CC}}=3.6 \mathrm{~V}$; Outputs High, $\mathrm{V}_{\mathrm{I}}=\mathrm{GND}$ or $\mathrm{V}_{\mathrm{CC}}, \mathrm{I}_{\mathrm{O}}=0$ |  |  | 0.05 | 0.1 | mA |
| ICCL |  | $\mathrm{V}_{\mathrm{CC}}=3.6 \mathrm{~V}$; Outputs Low, $\mathrm{V}_{\mathrm{I}}=\mathrm{GND}$ or $\mathrm{V}_{\mathrm{CC}}, \mathrm{l}_{\mathrm{O}}=0$ |  |  | 4.6 | 7.0 |  |
| Iccz |  | $\mathrm{V}_{\mathrm{CC}}=3.6 \mathrm{~V}$; Outputs Disabled; $\mathrm{V}_{\mathrm{I}}=\mathrm{GND}$ or $\mathrm{V}_{\mathrm{CC}}, \mathrm{IO}=0^{5}$ |  |  | 0.06 | 0.1 |  |
| $\Delta_{\text {l }} \mathrm{C}$ | Additional supply current per input pin ${ }^{2}$ | $\mathrm{V}_{\mathrm{CC}}=3 \mathrm{~V}$ to 3.6 V ; One input at $\mathrm{V}_{\mathrm{CC}}-0.6 \mathrm{~V}$, Other inputs at $\mathrm{V}_{\mathrm{CC}}$ or GND |  |  | 0.04 | 0.4 | mA |

## NOTES:

1. All typical values are at $\mathrm{V}_{\mathrm{CC}}=3.3 \mathrm{~V}$ and $\mathrm{T}_{\mathrm{amb}}=25^{\circ} \mathrm{C}$.
2. This is the increase in supply current for each input at the specified voltage level other than $\mathrm{V}_{\mathrm{CC}}$ or $G N D$
3. This parameter is valid for any $\mathrm{V}_{\mathrm{CC}}$ between 0 V and 1.2 V with a transition time of up to 10 msec . From $\mathrm{V}_{\mathrm{CC}}=1.2 \mathrm{~V}$ to $\mathrm{V}_{\mathrm{CC}}=3.3 \mathrm{~V} \pm 0.3 \mathrm{~V}$ a transition time of $100 \mu \mathrm{sec}$ is permitted. This parameter is valid for $\mathrm{T}_{\mathrm{amb}}=25^{\circ} \mathrm{C}$ only.
4. Unused pins at $\mathrm{V}_{\mathrm{CC}}$ or GND .
5. $I_{C C Z}$ is measured with outputs pulled up to $\mathrm{V}_{C C}$ or pulled down to ground.
6. For valid test results, data must not be loaded into the flip-flops (or latches) after applying power.
7. This is the bus hold overdrive current required to force the input to the opposite logic state.

AC CHARACTERISTICS (3.3V $\pm 0.3 \mathrm{~V}$ RANGE)
$\mathrm{GND}=0 \mathrm{~V} ; \mathrm{t}_{\mathrm{R}}=\mathrm{t}_{\mathrm{F}}=2.5 \mathrm{~ns} ; \mathrm{C}_{\mathrm{L}}=50 \mathrm{pF} ; \mathrm{R}_{\mathrm{L}}=500 \Omega ; \mathrm{T}_{\mathrm{amb}}=-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$.

| SYMBOL | PARAMETER | WAVEFORM | LIMITS |  |  | UNIT |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  |  | $\mathrm{V}_{\mathrm{cc}}=3.3 \mathrm{~V} \pm 0.3 \mathrm{~V}$ |  |  |  |
|  |  |  | MIN | TYP ${ }^{1}$ | MAX |  |
| tpLH $t_{\text {PHL }}$ | Propagation delay <br> An to Bn or Bn to An | 1 | $\begin{aligned} & 0.5 \\ & 0.5 \\ & \hline \end{aligned}$ | $\begin{aligned} & 1.5 \\ & 1.7 \end{aligned}$ | $\begin{aligned} & 2.7 \\ & 2.8 \\ & \hline \end{aligned}$ | ns |
| $\begin{aligned} & \text { tpLH } \\ & t_{\text {PHLL }} \\ & \hline \end{aligned}$ | Propagation delay <br> An to BPAR or Bn to APAR | 4 | $\begin{aligned} & 2.5 \\ & 2.0 \\ & \hline \end{aligned}$ | $\begin{aligned} & 5.0 \\ & 4.6 \\ & \hline \end{aligned}$ | $\begin{aligned} & 8.0 \\ & 7.3 \end{aligned}$ | ns |
| $\begin{aligned} & \text { tpLH } \\ & t_{\text {PHL }} \end{aligned}$ | Propagation delay <br> An to ERRA or Bn to ERRB | 5 | $\begin{aligned} & 2.5 \\ & 2.5 \end{aligned}$ | $\begin{aligned} & 7.8 \\ & 5.1 \end{aligned}$ | $\begin{aligned} & 11.5 \\ & 8.5 \end{aligned}$ | ns |
| $\begin{aligned} & \text { tpLH } \\ & \mathrm{t}_{\mathrm{PHLL}} \\ & \hline \end{aligned}$ | Propagation delay <br> APAR to BPAR or BPAR to APAR | 3 | $\begin{aligned} & 1.0 \\ & 1.0 \\ & \hline \end{aligned}$ | $\begin{aligned} & 2.9 \\ & 3.0 \end{aligned}$ | $\begin{aligned} & 6.9 \\ & 6.4 \\ & \hline \end{aligned}$ | ns |
| $\begin{aligned} & \mathrm{t}_{\mathrm{PLH}} \\ & \mathrm{t}_{\mathrm{PHLL}} \\ & \hline \end{aligned}$ | Propagation delay <br> APAR to ERRA or BPAR to ERRB | 8 | $\begin{aligned} & 2.5 \\ & 1.0 \\ & \hline \end{aligned}$ | $\begin{aligned} & 5.1 \\ & 2.5 \\ & \hline \end{aligned}$ | $\begin{aligned} & 8.0 \\ & 3.6 \\ & \hline \end{aligned}$ | ns |
| $\begin{aligned} & \hline \text { tpLH } \\ & t_{\text {PHL }} \end{aligned}$ | Propagation delay ODD/EVEN to APAR or BPAR | 7 | $\begin{aligned} & 1.5 \\ & 1.5 \\ & \hline \end{aligned}$ | $\begin{aligned} & 3.8 \\ & 3.4 \end{aligned}$ | $\begin{aligned} & 6.5 \\ & 5.4 \end{aligned}$ | ns |
| $\begin{aligned} & \hline \text { tPLH } \\ & t_{\text {PHL }} \\ & \hline \end{aligned}$ | Propagation delay ODD/EVEN to ERRA or ERRB | 6 | $\begin{aligned} & 2.5 \\ & 1.5 \\ & \hline \end{aligned}$ | $\begin{aligned} & 6.6 \\ & 4.0 \end{aligned}$ | $\begin{gathered} \hline 10.0 \\ 6.6 \\ \hline \end{gathered}$ | ns |
| $\begin{aligned} & \text { tpLH } \\ & \text { tpHL } \\ & \hline \end{aligned}$ | Propagation delay SEL to APAR or BPAR | 10 | $\begin{aligned} & 1.0 \\ & 1.0 \\ & \hline \end{aligned}$ | $\begin{aligned} & 2.6 \\ & 2.4 \end{aligned}$ | $\begin{aligned} & 4.0 \\ & 3.4 \end{aligned}$ | ns |
| $\begin{aligned} & \text { tpLH } \\ & \mathrm{t}_{\mathrm{PHL}} \end{aligned}$ | Propagation delay SEL to ERRA or ERRB | 5 | $\begin{aligned} & 2.5 \\ & 1.5 \end{aligned}$ | $\begin{aligned} & 7.8 \\ & 4.8 \\ & \hline \end{aligned}$ | $\begin{gathered} \hline 10.8 \\ 7.1 \end{gathered}$ | ns |
| $\begin{aligned} & \mathrm{t}_{\mathrm{PLH}} \\ & \mathrm{t}_{\mathrm{PHLL}} \\ & \hline \end{aligned}$ | Propagation delay LEA to Bn or LEB to An | 11 | $\begin{aligned} & 1.0 \\ & 1.0 \\ & \hline \end{aligned}$ | $\begin{aligned} & 2.2 \\ & 2.2 \\ & \hline \end{aligned}$ | $\begin{aligned} & 3.8 \\ & 3.8 \\ & \hline \end{aligned}$ | ns |
| $\begin{aligned} & \text { tpLH } \\ & t_{\text {PHLL }} \\ & \hline \end{aligned}$ | Propagation delay <br> LEA to BPAR or LEB to APAR | 11 | $\begin{aligned} & 2.5 \\ & 2.0 \\ & \hline \end{aligned}$ | $\begin{aligned} & 5.3 \\ & 4.9 \\ & \hline \end{aligned}$ | $\begin{aligned} & 8.5 \\ & 7.6 \end{aligned}$ | ns |
| $\begin{aligned} & \hline \mathrm{tPLH}^{\prime} \\ & \mathrm{t}_{\mathrm{PHL}} \end{aligned}$ | Propagation delay <br> LEA to ERRA or LEB to ERRB | 9 | $\begin{aligned} & 2.5 \\ & 2.5 \\ & \hline \end{aligned}$ | $\begin{array}{r} 7.4 \\ 5.6 \\ \hline \end{array}$ | $\begin{gathered} 11.0 \\ 9.2 \\ \hline \end{gathered}$ | ns |
| $\begin{aligned} & \text { tpzH } \\ & t_{\text {PZLL }} \end{aligned}$ | Output enable time OEA to An, APAR or OEB to Bn, BPAR | 13, 14 | $\begin{aligned} & 1.0 \\ & 0.5 \\ & \hline \end{aligned}$ | $\begin{aligned} & 2.4 \\ & 1.8 \end{aligned}$ | $\begin{aligned} & 5.8 \\ & 3.3 \end{aligned}$ | ns |
| $\begin{aligned} & \text { tpHz } \\ & \text { tpLZ } \\ & \hline \end{aligned}$ | Output disable time OEA to An, APAR or OEB to Bn, BPAR | 13, 14 | 2.5 1.0 | $\begin{aligned} & 5.2 \\ & 2.4 \\ & \hline \end{aligned}$ | $\begin{aligned} & 8.0 \\ & 3.5 \\ & \hline \end{aligned}$ | ns |

NOTE:

1. All typical values are at $\mathrm{V}_{\mathrm{CC}}=3.3 \mathrm{~V}$ and $\mathrm{T}_{\mathrm{amb}}=25^{\circ} \mathrm{C}$.

AC SETUP REQUIREMENTS ( $3.3 \mathrm{~V} \pm 0.3 \mathrm{~V}$ RANGE)
$\mathrm{GND}=0 \mathrm{~V} ; \mathrm{t}_{\mathrm{R}}=\mathrm{t}_{\mathrm{F}}=2.5 \mathrm{~ns} ; \mathrm{C}_{\mathrm{L}}=50 \mathrm{pF}, \mathrm{R}_{\mathrm{L}}=500 \Omega$

| SYMBOL | PARAMETER | WAVEFORM |  |  | UNIT |
| :---: | :---: | :---: | :---: | :---: | :---: |
|  |  |  | $\mathrm{V}_{\mathrm{Cc}}=3.3 \mathrm{~V} \pm 0.3 \mathrm{~V}$ |  |  |
|  |  |  | MIN | TYP |  |
| $\begin{aligned} & \hline \mathrm{t}_{\mathrm{s}}(\mathrm{H}) \\ & \mathrm{t}_{\mathrm{s}}(\mathrm{~L}) \end{aligned}$ | Setup time, High or Low <br> An, APAR to LEA or Bn, BPAR to LEB | 12 | $\begin{aligned} & 1.0 \\ & 1.0 \end{aligned}$ | $\begin{aligned} & 0.1 \\ & 0.1 \end{aligned}$ | ns |
| $\begin{aligned} & \hline \mathrm{t}_{\mathrm{n}}(\mathrm{H}) \\ & \mathrm{t}_{\mathrm{h}}(\mathrm{~L}) \\ & \hline \end{aligned}$ | Hold time, High or Low <br> An, APAR to LEA or Bn, BPAR to LEB | 12 | $\begin{aligned} & 1.0 \\ & 1.0 \end{aligned}$ | $\begin{gathered} \hline-0.1 \\ 0.1 \end{gathered}$ | ns |
| $\mathrm{t}_{\mathrm{w}}(\mathrm{H})$ | Pulse width, High LEA or LEB | 12 | 1.0 | - | ns |

### 2.5V/3.3V 18-bit latched transceiver with 16-bit parity generator/checker (3-State)

## DC ELECTRICAL CHARACTERISTICS (2.5V $\pm 0.2 \mathrm{~V}$ RANGE)

| SYMBOL | PARAMETER | TEST CONDITIONS |  |  | IMITS |  | UNIT |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  |  |  | Temp $=-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$ |  |  |  |
|  |  |  |  | MIN | TYP ${ }^{1}$ | MAX |  |
| $\mathrm{V}_{\mathrm{IK}}$ | Input clamp voltage | $\mathrm{V}_{\mathrm{CC}}=2.3 \mathrm{~V} ; \mathrm{I}_{\mathrm{IK}}=-18 \mathrm{~mA}$ |  |  | -0.85 | -1.2 | V |
| $\mathrm{VOH}_{\mathrm{OH}}$ | High-level output voltage | $\mathrm{V}_{\mathrm{CC}}=2.3$ to $3.6 \mathrm{~V} ; \mathrm{l}_{\mathrm{OH}}=-100 \mu \mathrm{~A}$ |  | $\mathrm{V}_{\mathrm{CC}}-0.2$ | $\mathrm{V}_{\text {cc }}$ |  | V |
|  |  | $\mathrm{V}_{\mathrm{CC}}=2.3 \mathrm{~V} ; \mathrm{I}_{\mathrm{OH}}=-8 \mathrm{~mA}$ |  | 1.8 | 2.5 |  |  |
| $\mathrm{V}_{\text {OL }}$ | Low-level output voltage | $\mathrm{V}_{\mathrm{CC}}=2.3 \mathrm{~V} ; \mathrm{l}_{\mathrm{OL}}=100 \mu \mathrm{~A}$ |  |  | 0.07 | 0.2 | V |
|  |  | $\mathrm{V}_{\mathrm{CC}}=2.3 \mathrm{~V} ; \mathrm{l}_{\mathrm{OL}}=24 \mathrm{~mA}$ |  |  | 0.3 | 0.5 |  |
|  |  | $\mathrm{V}_{\mathrm{CC}}=2.3 \mathrm{~V}$; $\mathrm{l}_{\mathrm{OL}}=8 \mathrm{~mA}$ |  |  |  | 0.4 |  |
| $\mathrm{V}_{\text {RST }}$ | Power-up output low voltage ${ }^{7}$ | $\mathrm{V}_{\mathrm{CC}}=2.7 \mathrm{~V} ; \mathrm{I}_{\mathrm{O}}=1 \mathrm{~mA} ; \mathrm{V}_{\mathrm{I}}=\mathrm{V}_{\mathrm{CC}}$ or GND |  |  |  | 0.55 | V |
| 1 | Input leakage current | $\mathrm{V}_{\mathrm{CC}}=2.7 \mathrm{~V} ; \mathrm{V}_{\mathrm{I}}=\mathrm{V}_{\mathrm{CC}}$ or GND | Control pins |  | 0.1 | $\pm 1$ | $\mu \mathrm{A}$ |
|  |  | $\mathrm{V}_{\mathrm{CC}}=0$ or 2.7 V ; $\mathrm{V}_{1}=5.5 \mathrm{~V}$ |  |  | 0.1 | 10 |  |
|  |  | $\mathrm{V}_{\mathrm{CC}}=2.7 \mathrm{~V} ; \mathrm{V}_{\mathrm{I}}=5.5 \mathrm{~V}$ | Data pins ${ }^{4}$ |  | 0.1 | 20 |  |
|  |  | $\mathrm{V}_{\mathrm{CC}}=2.7 \mathrm{~V} ; \mathrm{V}_{\mathrm{I}}=\mathrm{V}_{\mathrm{CC}}$ |  |  | 0.1 | 10 |  |
|  |  |  |  |  | 0.1 | -5 |  |
| IOFF | Off current | $\mathrm{V}_{\mathrm{CC}}=0 \mathrm{~V} ; \mathrm{V}_{\mathrm{I}} \text { or } \mathrm{V}_{\mathrm{O}}=0 \text { to } 4.5 \mathrm{~V}$ |  |  | 0.1 | $\pm 100$ | $\mu \mathrm{A}$ |
| Ihold ${ }^{6}$ | Bus Hold current Data inputs | $\mathrm{V}_{\mathrm{CC}}=2.3 \mathrm{~V} ; \mathrm{V}_{\mathrm{I}}=0.7 \mathrm{~V}$ |  |  | 115 |  | $\mu \mathrm{A}$ |
|  |  | $\mathrm{V}_{\mathrm{CC}}=2.3 \mathrm{~V} ; \mathrm{V}_{\mathrm{I}}=1.7 \mathrm{~V}$ |  |  | 10 |  | $\mu \mathrm{A}$ |
| $l_{\text {EX }}$ | Current into an output in the High state when $\mathrm{V}_{\mathrm{O}}>\mathrm{V}_{\mathrm{CC}}$ | $\mathrm{V}_{\mathrm{O}}=5.5 \mathrm{~V} ; \mathrm{V}_{\mathrm{CC}}=2.3 \mathrm{~V}$ |  |  | 10 | 125 | $\mu \mathrm{A}$ |
| IPU/PD | Power up/down 3-State output current ${ }^{3}$ | $\begin{aligned} & \mathrm{V}_{\mathrm{CC}} \leq 1.2 \mathrm{~V} ; \mathrm{V}_{\mathrm{O}}=0.5 \mathrm{~V} \text { to } \mathrm{V}_{\mathrm{CC}} ; \mathrm{V}_{\mathrm{I}}=\mathrm{GND} \text { or } \mathrm{V}_{\mathrm{CC}} ; \\ & \mathrm{OE} / \mathrm{OE}=\text { Don't care } \end{aligned}$ |  |  | 33 | $\pm 100$ | $\mu \mathrm{A}$ |
| lozh | 3-State output High current | $\mathrm{V}_{\mathrm{CC}}=2.7 \mathrm{~V} ; \mathrm{V}_{\mathrm{O}}=2.3 \mathrm{~V} ; \mathrm{V}_{\mathrm{I}}=\mathrm{V}_{\mathrm{IL}}$ or $\mathrm{V}_{\mathrm{IH}}$ |  |  | 0.5 | 5 | $\mu \mathrm{A}$ |
| lozl | 3-State output Low current | $\mathrm{V}_{\mathrm{CC}}=2.7 \mathrm{~V} ; \mathrm{V}_{\mathrm{O}}=0.5 \mathrm{~V} ; \mathrm{V}_{\mathrm{I}}=\mathrm{V}_{\text {IL }}$ or $\mathrm{V}_{\mathrm{IH}}$ |  |  | 0.5 | -5 | $\mu \mathrm{A}$ |
| $\mathrm{I}_{\mathrm{CCH}}$ | Quiescent supply current | $\mathrm{V}_{\mathrm{CC}}=2.7 \mathrm{~V}$; Outputs High, $\mathrm{V}_{\mathrm{I}}=\mathrm{GND}$ or $\mathrm{V}_{\mathrm{Cc}}, \mathrm{I}_{\mathrm{O}}=0$ |  |  | 0.04 | 0.1 |  |
| $\mathrm{I}_{\text {CCL }}$ |  | $\mathrm{V}_{\mathrm{CC}}=2.7 \mathrm{~V}$; Outputs Low, $\mathrm{V}_{\mathrm{I}}=\mathrm{GND}$ or $\mathrm{V}_{\mathrm{CC}}, \mathrm{I}_{\mathrm{O}}=0$ |  |  | 3.5 | 4.5 | mA |
| ICCz |  | $\mathrm{V}_{\mathrm{CC}}=2.7 \mathrm{~V}$; Outputs Disabled; $\mathrm{V}_{\mathrm{I}}=\mathrm{GND}$ or $\mathrm{V}_{\mathrm{CC}}, \mathrm{I}_{\mathrm{O}}=0^{5}$ |  |  | 0.04 | 0.1 |  |
| $\Delta_{\text {l }} \mathrm{C}$ | Additional supply current per input pin ${ }^{2}$ | $\begin{aligned} & \hline \mathrm{V}_{\mathrm{CC}}=2.3 \mathrm{~V} \text { to } 2.7 \mathrm{~V} \text {; One input at } \mathrm{V}_{\mathrm{CC}}-0.6 \mathrm{~V} \text {, } \\ & \text { Other inputs at } \mathrm{V}_{\mathrm{CC}} \text { or } \mathrm{GND} \end{aligned}$ |  |  | 0.04 | 0.4 | mA |

## NOTES:

1. All typical values are at $\mathrm{V}_{\mathrm{CC}}=2.5 \mathrm{~V}$ and $\mathrm{T}_{\mathrm{amb}}=25^{\circ} \mathrm{C}$.
2. This is the increase in supply current for each input at the specified voltage level other than $\mathrm{V}_{\mathrm{CC}}$ or GND
3. This parameter is valid for any $\mathrm{V}_{\mathrm{C}}$ between 0 V and 1.2 V with a transition time of up to 10 msec . From $\mathrm{V}_{\mathrm{CC}}=1.2 \mathrm{~V}$ to $\mathrm{V}_{\mathrm{CC}}=2.5 \mathrm{~V} \pm 0.2 \mathrm{~V}$ a transition time of $100 \mu \mathrm{sec}$ is permitted. This parameter is valid for $\mathrm{Tamb}=25^{\circ} \mathrm{C}$ only.
4. Unused pins at $\mathrm{V}_{\mathrm{CC}}$ or GND.
5. $I_{C C Z}$ is measured with outputs pulled up to $\mathrm{V}_{\mathrm{CC}}$ or pulled down to ground.
6. Not guaranteed.
7. For valid test results, data must not be loaded into the flip-flops (or latches) after applying power.

AC CHARACTERISTICS ( $2.5 \mathrm{~V} \pm 0.2 \mathrm{~V}$ RANGE)
$\mathrm{GND}=0 \mathrm{~V} ; \mathrm{t}_{\mathrm{R}}=\mathrm{t}_{\mathrm{F}}=2.5 \mathrm{~ns} ; \mathrm{C}_{\mathrm{L}}=50 \mathrm{pF} ; \mathrm{R}_{\mathrm{L}}=500 \Omega ; \mathrm{T}_{\mathrm{amb}}=-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$.

| SYMBOL | PARAMETER | WAVEFORM | LIMITS |  |  | UNIT |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  |  | $\mathrm{V}_{\mathrm{CC}}=2.5 \mathrm{~V} \pm 0.2 \mathrm{~V}$ |  |  |  |
|  |  |  | MIN | TYP ${ }^{1}$ | MAX |  |
| $\begin{aligned} & \text { tPLH } \\ & t_{\text {tPHL }} \end{aligned}$ | Propagation delay <br> An to Bn or Bn to An | 1 | $\begin{aligned} & 1.0 \\ & 1.0 \end{aligned}$ | $\begin{aligned} & 2.0 \\ & 2.2 \end{aligned}$ | $\begin{aligned} & 3.5 \\ & 3.9 \end{aligned}$ | ns |
| $\begin{aligned} & \text { tpLH } \\ & t_{\text {PPHL }} \end{aligned}$ | Propagation delay <br> An to BPAR or Bn to APAR | 4 | $\begin{aligned} & 3.0 \\ & 3.0 \end{aligned}$ | $\begin{aligned} & 7.0 \\ & 6.5 \end{aligned}$ | $\begin{aligned} & 10.5 \\ & 10.2 \end{aligned}$ | ns |
| $\begin{aligned} & \text { tpLH } \\ & t_{\text {PPHL }} \end{aligned}$ | Propagation delay <br> An to ERRA or Bn to ERRB | 5 | $\begin{aligned} & 4.5 \\ & 3.5 \end{aligned}$ | $\begin{aligned} & 9.8 \\ & 7.0 \end{aligned}$ | $\begin{aligned} & 14.5 \\ & 11.5 \end{aligned}$ | ns |
| $\begin{aligned} & \text { tPLH } \\ & \text { tpHL } \\ & \hline \end{aligned}$ | Propagation delay <br> APAR to BPAR or BPAR to APAR | 3 | $\begin{aligned} & 1.0 \\ & 1.0 \end{aligned}$ | $\begin{aligned} & 3.0 \\ & 3.5 \end{aligned}$ | $\begin{aligned} & 4.3 \\ & 5.5 \end{aligned}$ | ns |
| $\begin{aligned} & \hline \text { tpLH } \\ & t_{\text {tPHL }} \\ & \hline \end{aligned}$ | Propagation delay <br> APAR to ERRA or BPAR to ERRB | 8 | $\begin{aligned} & 3.0 \\ & 1.5 \end{aligned}$ | $\begin{aligned} & 6.7 \\ & 3.6 \end{aligned}$ | $\begin{gathered} 10.0 \\ 5.4 \\ \hline \end{gathered}$ | ns |
| $\begin{aligned} & \text { tpLH } \\ & t_{\text {PHL }} \end{aligned}$ | Propagation delay ODD/EVEN to APAR or BPAR | 7 | $\begin{aligned} & 2.5 \\ & 2.5 \end{aligned}$ | $\begin{aligned} & 5.2 \\ & 5.0 \end{aligned}$ | $\begin{aligned} & 7.8 \\ & 7.8 \end{aligned}$ | ns |
| $\begin{aligned} & \text { tple } \\ & t_{\text {tPHL }} \end{aligned}$ | Propagation delay ODD/EVEN to ERRA or ERRB | 6 | $\begin{aligned} & 4.0 \\ & 4.0 \end{aligned}$ | $\begin{aligned} & 8.6 \\ & 8.1 \end{aligned}$ | $\begin{aligned} & 12.0 \\ & 10.6 \end{aligned}$ | ns |
| $\begin{aligned} & \text { tpLH } \\ & t_{\text {tPHL }} \end{aligned}$ | Propagation delay SEL to APAR or BPAR | 10 | $\begin{aligned} & 1.5 \\ & 1.5 \end{aligned}$ | $\begin{aligned} & 3.7 \\ & 3.2 \end{aligned}$ | $\begin{aligned} & 5.5 \\ & 5.3 \end{aligned}$ | ns |
| $\begin{aligned} & \text { tpLH } \\ & \text { tPHL }^{\prime} \\ & \hline \end{aligned}$ | Propagation delay SEL to ERRA or ERRB | 5 | $\begin{aligned} & 4.5 \\ & 3.0 \\ & \hline \end{aligned}$ | $\begin{aligned} & 9.4 \\ & 7.6 \\ & \hline \end{aligned}$ | $\begin{aligned} & 14.0 \\ & 11.5 \end{aligned}$ | ns |
| $\begin{aligned} & \text { tPLH } \\ & t_{\text {PPHL }} \\ & \hline \end{aligned}$ | Propagation delay <br> LEA to Bn or LEB to An | 11 | $\begin{aligned} & 1.0 \\ & 1.0 \end{aligned}$ | $\begin{aligned} & 3.0 \\ & 3.0 \end{aligned}$ | $\begin{aligned} & 4.8 \\ & 4.6 \end{aligned}$ | ns |
| $\begin{aligned} & \text { tpLH } \\ & t_{\text {PHL }} \end{aligned}$ | Propagation delay <br> LEA to BPAR or LEB to APAR | 11 | $\begin{aligned} & 2.5 \\ & 2.5 \\ & \hline \end{aligned}$ | $\begin{aligned} & 7.5 \\ & 7.4 \\ & \hline \end{aligned}$ | $\begin{aligned} & 12.2 \\ & 11.2 \\ & \hline \end{aligned}$ | ns |
| $\begin{aligned} & \mathrm{tpLH}^{\text {tpH }} \\ & \mathrm{tpH}^{2} \end{aligned}$ | Propagation delay <br> LEA to ERRA or LEB to ERRB | 9 | $\begin{aligned} & 4.5 \\ & 3.5 \end{aligned}$ | $\begin{aligned} & 9.7 \\ & 8.5 \end{aligned}$ | $\begin{aligned} & 15.0 \\ & 13.4 \end{aligned}$ | ns |
| $\begin{aligned} & \mathrm{t}_{\mathrm{PLZH}} \\ & \mathrm{t}_{\text {PZL }} \end{aligned}$ | Output enable time OEA to An, APAR or OEB to Bn, BPAR | 13, 14 | $\begin{aligned} & 1.5 \\ & 1.0 \end{aligned}$ | $\begin{aligned} & 4.0 \\ & 2.6 \end{aligned}$ | $\begin{aligned} & 6.0 \\ & 4.6 \end{aligned}$ | ns |
| $\begin{aligned} & \text { tpHz } \\ & \text { tpLZ } \end{aligned}$ | Output disable time OEA to An, APAR or OEB to Bn, BPAR | 13, 14 | $\begin{aligned} & 1.5 \\ & 1.0 \end{aligned}$ | $\begin{aligned} & 4.5 \\ & 3.7 \end{aligned}$ | $\begin{aligned} & 6.5 \\ & 5.0 \end{aligned}$ | ns |

NOTE:

1. All typical values are at $\mathrm{V}_{\mathrm{CC}}=2.5 \mathrm{~V}$ and $\mathrm{T}_{\mathrm{amb}}=25^{\circ} \mathrm{C}$.

AC SETUP REQUIREMENTS ( $2.5 \mathrm{~V} \pm 0.2 \mathrm{~V}$ RANGE)
GND $=0 \mathrm{~V} ; \mathrm{t}_{\mathrm{R}}=\mathrm{t}_{\mathrm{F}}=2.5 \mathrm{~ns} ; \mathrm{C}_{\mathrm{L}}=50 \mathrm{pF}, \mathrm{R}_{\mathrm{L}}=500 \Omega ; \mathrm{T}_{\mathrm{amb}}=-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$.

| SYMBOL | PARAMETER | WAVEFORM | LIMITS |  | UNIT |
| :---: | :---: | :---: | :---: | :---: | :---: |
|  |  |  | $\mathrm{V}_{\mathrm{CC}}=2.5 \mathrm{~V} \pm 0.2 \mathrm{~V}$ |  |  |
|  |  |  | MIN | TYP |  |
| $\begin{aligned} & \mathrm{t}_{\mathrm{s}}(\mathrm{H}) \\ & \mathrm{t}_{\mathrm{s}}(\mathrm{~L}) \end{aligned}$ | Setup time, High or Low An, APAR to LEA or Bn, BPAR to LEB | 12 | $\begin{gathered} -1.0 \\ 1.2 \end{gathered}$ | $\begin{gathered} -0.4 \\ 0.4 \end{gathered}$ | ns |
| $\begin{aligned} & \mathrm{t}_{\mathrm{h}}(\mathrm{H}) \\ & \mathrm{t}_{\mathrm{h}}(\mathrm{~L}) \end{aligned}$ | Hold time, High or Low An, APAR to LEA or Bn, BPAR to LEB | 12 | $\begin{gathered} -1.0 \\ 1.2 \\ \hline \end{gathered}$ | $\begin{gathered} -0.4 \\ 0.5 \end{gathered}$ | ns |
| $t_{w}(\mathrm{H})$ | Pulse width, High LEA or LEB | 12 | 1.0 | - | ns |

### 2.5V/3.3V 18-bit latched transceiver with 16-bit parity generator/checker (3-State)

## AC WAVEFORMS



Waveform 1. Input ( nAx ) to Output ( $\mathrm{n} Y \mathrm{x}$ ) Propagation Delays


Waveform 2. 3-State Output Enable and Disable Times


Waveform 3. Propagation Delay, An to Bn, Bn to An, APAR to BPAR, BPAR to APAR


Waveform 4. Propagation Delay, An to BPAR or Bn to APAR


NOTE: Only even parity mode is shown, odd parity mode would be with ODD/EVEN = 1
Waveform 5. Propagation Delay, An to ERRA or Bn to ERRB


Waveform 6. Propagation Delay, ODD/EVEN to ERRA or ODD/EVEN to ERRB

### 2.5V/3.3V 18-bit latched transceiver with 16-bit parity generator/checker (3-State)



Waveform 7. Propagation Delay, ODD/EVEN to APAR or ODD/EVEN to BPAR


NOTE: Only even parity mode is shown with even parity. Odd parity mode would cause inverted output and odd parity mode would be with ODD/EVEN = 1

## Waveform 8. Propagation Delay, APAR to ERRA or BPAR to ERRB

### 2.5V/3.3V 18-bit latched transceiver with 16-bit parity generator/checker (3-State)



Waveform 9. Propagation Delay, LEA to ERRA or LEB to ERRB


Waveform 10. Propagation Delay, SEL to BPAR or SEL to APAR

### 2.5V/3.3V 18-bit latched transceiver with 16-bit parity generator/checker (3-State)



Waveform 11. Propagation Delay, LEA to BPAR or LEB to APAR, LEA to Bn or LEB to An


The shaded areas indicate when the input is permitted to change for predictable output performance.
SA00302
Waveform 12. Data Setup and Hold Times, Pulse Width High


Waveform 13. 3-State Output Enable Time to High Level and Output Disable Time from High Level


Waveform 14. 3-State Output Enable Time to Low Level and Output Disable Time from Low Level

### 2.5V/3.3V 18-bit latched transceiver with 16-bit parity generator/checker (3-State)

## TEST CIRCUIT AND WAVEFORM



### 2.5V/3.3V 18-bit latched transceiver with 16-bit parity generator/checker (3-State)


detail X


DIMENSIONS (mm are the original dimensions)

| UNIT | A max. | $\mathrm{A}_{1}$ | $\mathrm{A}_{2}$ | $\mathrm{A}_{3}$ | $b_{p}$ | c | $\mathrm{D}^{(1)}$ | $E^{(1)}$ | e | $\mathrm{H}_{\mathrm{E}}$ | L | $L_{p}$ | Q | v | w | y | $\mathbf{Z}^{(1)}$ | $\theta$ |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| mm | 2.8 | $\begin{aligned} & 0.4 \\ & 0.2 \end{aligned}$ | $\begin{aligned} & 2.35 \\ & 2.20 \end{aligned}$ | 0.25 | $\begin{aligned} & 0.3 \\ & 0.2 \end{aligned}$ | $\begin{aligned} & 0.22 \\ & 0.13 \end{aligned}$ | $\begin{aligned} & 18.55 \\ & 18.30 \end{aligned}$ | $\begin{aligned} & 7.6 \\ & 7.4 \end{aligned}$ | 0.635 | $\begin{aligned} & 10.4 \\ & 10.1 \end{aligned}$ | 1.4 | $\begin{aligned} & 1.0 \\ & 0.6 \end{aligned}$ | $\begin{aligned} & 1.2 \\ & 1.0 \end{aligned}$ | 0.25 | 0.18 | 0.1 | $\begin{aligned} & 0.85 \\ & 0.40 \end{aligned}$ | $8^{\circ}$ $0^{\circ}$ |

Note

1. Plastic or metal protrusions of 0.25 mm maximum per side are not included.

| OUTLINE <br> VERSION | REFERENCES |  |  |  | EUROPEAN <br> PROJJECTION | ISSUE DATE |
| :--- | :---: | :---: | :---: | :---: | :---: | :---: |
|  | IEC | JEDEC | EIAJ |  |  |  |
| SOT371-1 |  | MO-118AB |  |  | $-93-11-02$ |  |



MSA400

Dimensions in mm.

NOTES
2.5V/3.3V 18-bit latched transceiver with 16-bit parity generator/checker (3-State)

Data sheet status

| Data sheet <br> status | Product <br> status | Definition [1] |
| :--- | :--- | :--- |
| Objective <br> specification | Development | This data sheet contains the design target or goal specifications for product development. <br> Specification may change in any manner without notice. |
| Preliminary <br> specification | Qualification | This data sheet contains preliminary data, and supplementary data will be published at a later date. <br> Philips Semiconductors reserves the right to make chages at any time without notice in order to <br> improve design and supply the best possible product. |
| Product <br> specification | Production | This data sheet contains final specifications. Philips Semiconductors reserves the right to make <br> changes at any time without notice in order to improve design and supply the best possible product. |

[1] Please consult the most recently issued datasheet before initiating or completing a design.

## Definitions

Short-form specification - The data in a short-form specification is extracted from a full data sheet with the same type number and title. For detailed information see the relevant data sheet or data handbook.
Limiting values definition - Limiting values given are in accordance with the Absolute Maximum Rating System (IEC 134). Stress above one or more of the limiting values may cause permanent damage to the device. These are stress ratings only and operation of the device at these or at any other conditions above those given in the Characteristics sections of the specification is not implied. Exposure to limiting values for extended periods may affect device reliability.
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